

**Search Notes**

Application/Control No.

10/665,350

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under  
Reexamination

KINKELAAR ET AL.

Art Unit

1745

**SEARCHED**

Class	Subclass	Date	Examiner
429	34	12/20/2006	DWY
429	35	12/20/2006	DWY
429	38	12/20/2006	DWY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	12/20/2006	DWY